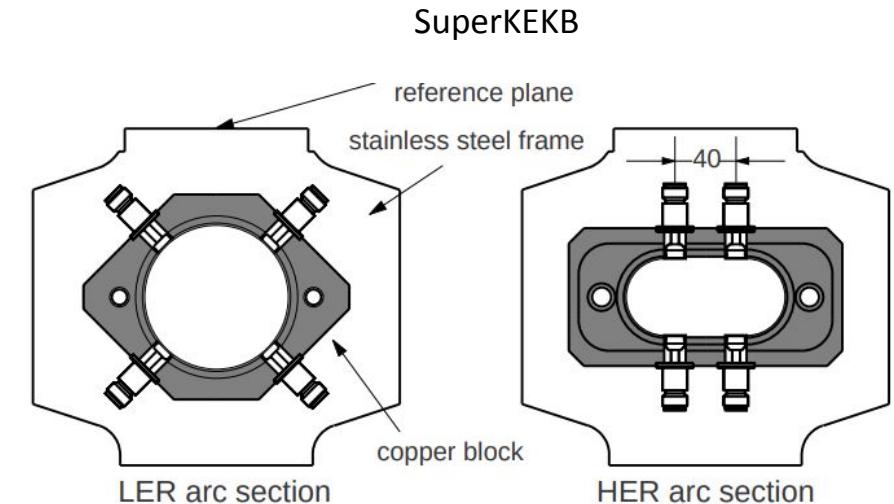
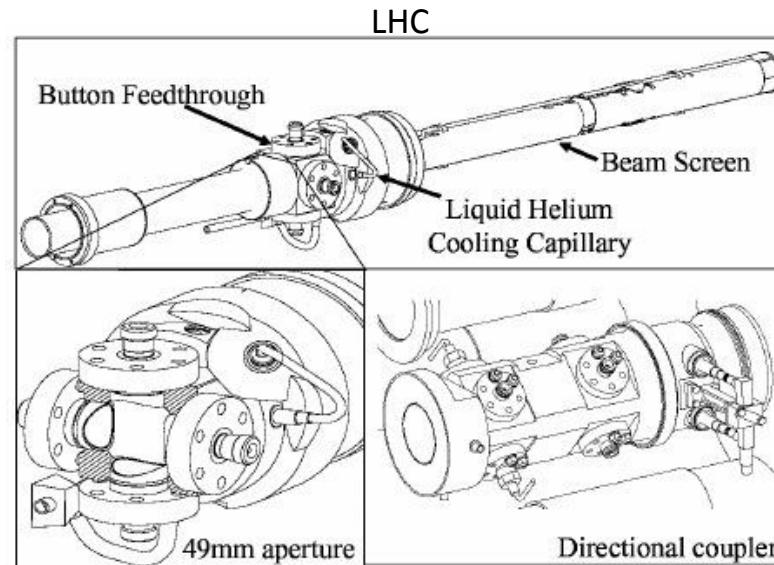


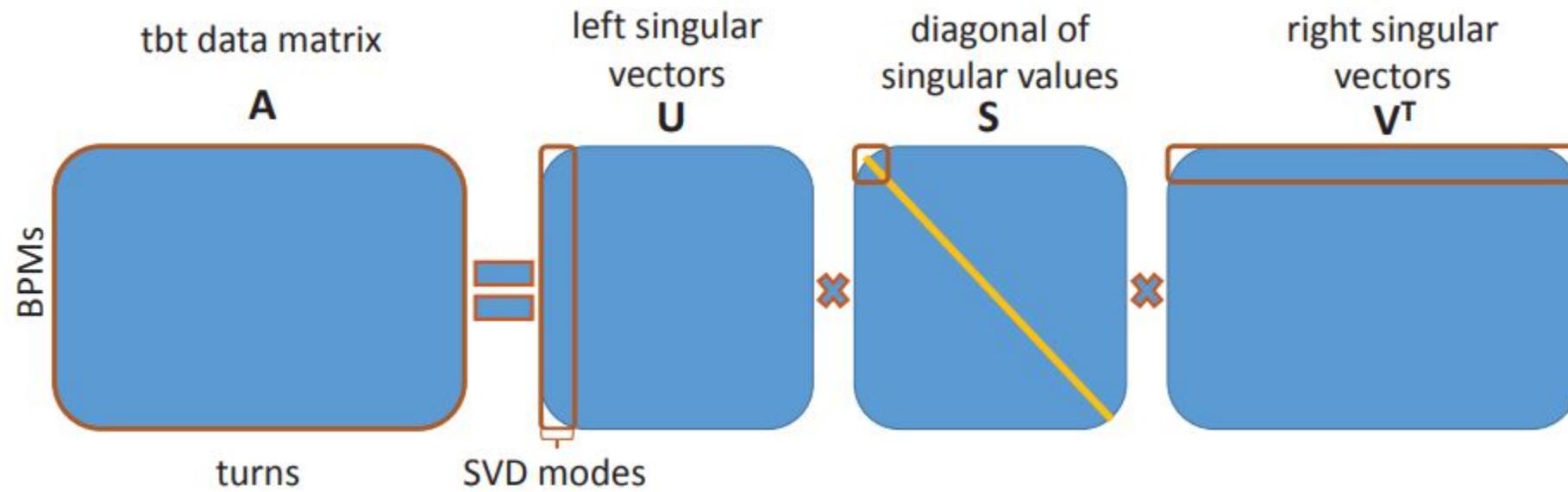
Turn-by-turn Beam Position Measurement precision (noise) in various accelerators



M. Hofer, A. Huschauer, J. Keintzel, M. Le Garrec, E.H. Maclean, L. Malina, T. Persson, R. Tomas and A. Wegscheider.



Singular Value Decomposition of Turn-by-turn BPM data



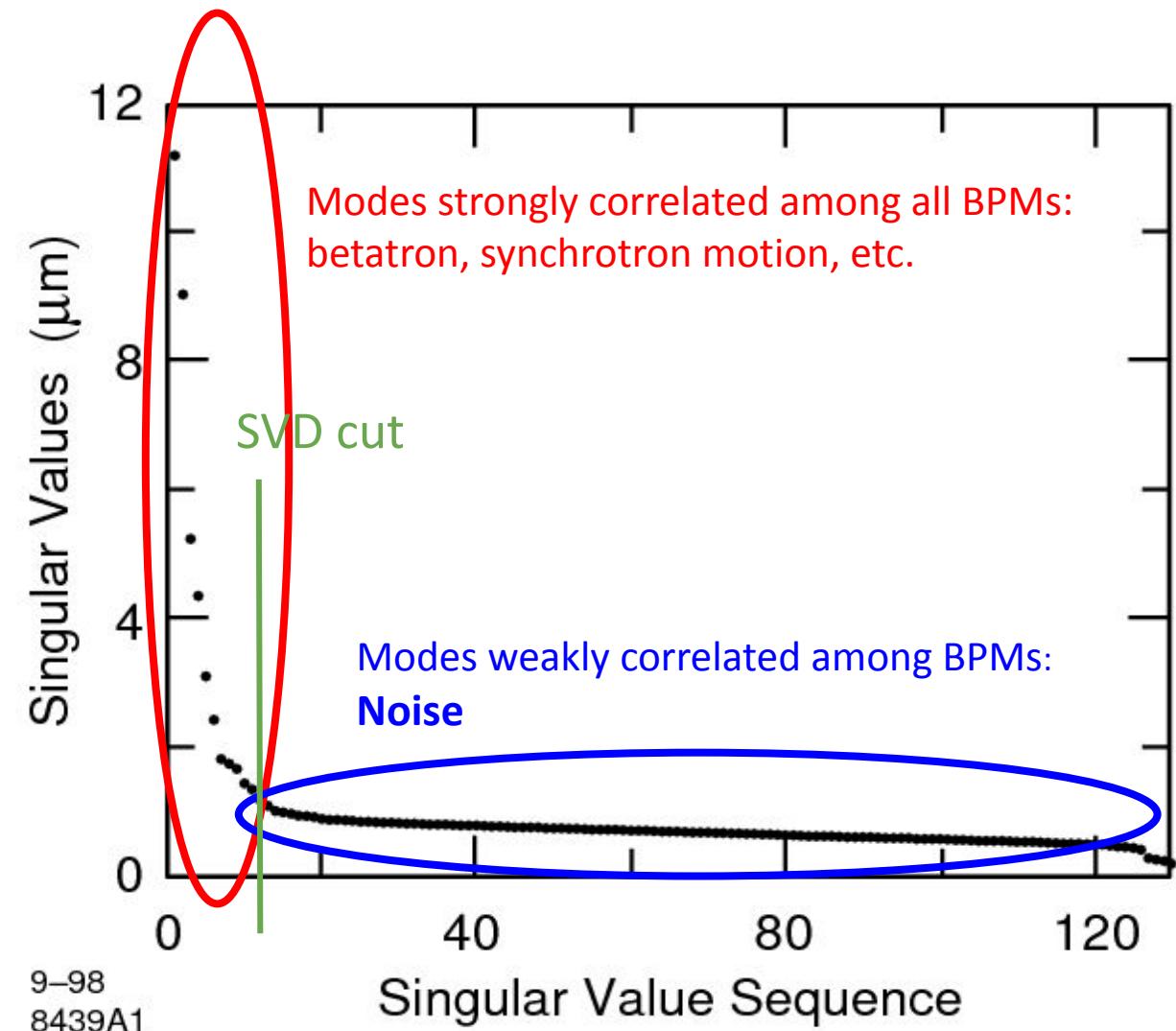
U and V are unitary matrices and their columns are orthonormal.

S is a diagonal matrix containing the singular values in descending order.

Singular Values and measurement Noise

The contribution from the weak singular modes to the signal is interpreted as the measurement **Noise**.

There is some arbitrariness in the choice of the **SVD cut**



BPM noise as measured from SVD analysis of Turn-by-Turn data

Machine	Noise in TbT measurements [μm]	Bunch intensity [10^{10}cpb]	Number of bunches	Bunch length [mm]	BPM/beam screen diameter [mm]
ESRF	<u>10</u>	0.04	330		79 x 33
ALBA	<u>14</u>	0.1	45	6	<u>72 x 28</u>
PETRA	22	23	1-5	<u>13.2</u>	<u>octants: 80x40, 80x38; straight sections: 94 undulators: 66x11, 57x7; wigglers: 120x30, 60x26</u>
LHC	<u>100</u>	1	1	70	49
SKEKB LER/HER*	200 / 125	6	1		<u>LER 94 / HER 104 x 50</u>
PS	200	10	1		<u>166 x 80</u>
PSB	30	30	1		<u>140</u>
IOTA (similar to ATF2 BPM design)	<u>100</u>	0.067	1		<u>47.5</u>

*In SKEKB with 8mA (multibunch) a BPM noise of about 50 μm was observed